



<b>Document Title:</b> long term Storage	<b>Document Number:</b> ND00007
<b>Description:</b> Die or Assembly storage	<b>Doc:</b> Storage presentation
<b>Confidential</b>	<b>Page</b> .....1..... <b>of</b> .....40.....

# Long-term storage: Die or assembly?

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1	9/03/10	MS	Eng

# Long-term storage: Die or assembly?

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# To store, or not to store

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- ✓ Commercial decision
    - ✓ Insurance policy
    - ✓ Cost of “insurance”
    - ✓ Storage strategy
  - ✓ Conscious decision
    - ✓ Storage by design or storage by accident?
  - ✓ Is it a unique or custom product ?
    - ✓ Analyse risks of non-availability
    - ✓ Do I own any of the IPR ?
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# Initial Considerations

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- ✓ The “device” is to be supplied in predictable quantities over the next 25 years.
- ✓ The “device” will be deemed “fit-for-purpose” at any stage during it’s 25 year “shelf life”.
- ✓ Question ... does the “device” have to meet future and unknown legislation ?

# What to store

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- ✓ Level of “importance” of each item
  - ✓ Again ... look at level of customization
- ✓ Do I have to store it ?
  - ✓ or will my feed & supply chain do it for me
  - ✓ Level of trust / reliance
- ✓ What state is my item in?
  - ✓ Can I store it ?
  - ✓ Will it store ?
    - ✓ Shelf life, known issues, legislation ?
  - ✓ Anything special ?
    - ✓ Handling & storage training ?

# Storing as Assembled product ... the criteria

- ✓ The “device” is going to be stored for up to 25 years.
  - ✓ The “device” must be “process-able” after storage
    - ✓ Lead finish
    - ✓ Final lead preparation
    - ✓ Package integrity
    - ✓ Caution : newer “processing” methods and standards
  - ✓ The “device” (once processed) will be expected to work as if it were a new device.
  - ✓ The inherent reliability or specification of the “device” shall not be compromised.
    - ✓ Warrantees ... expressed or implied
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# Storing as Die / Wafer product ... the criteria

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- ✓ The die or wafer is going to be stored for up to 25 years.
  - ✓ The die must be “process-able” after storage
    - ✓ To manufacture a suitable “device”
  - ✓ The “device” (once assembled) will be expected to work as if it were a new device.
  - ✓ The inherent reliability or specification of the “device” shall not be compromised.
    - ✓ Again, warranties, expressed or implied
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## Date codes, batch numbers, traceability

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- ✓ Only **TESTED** product should be stored.
  - ✓ Only GOOD product ... remember!
- ✓ Storage security
  - ✓ Are the devices physically secure
  - ✓ Is a paper “ring-fence” good enough?
  - ✓ Is barbed wire seen as OTT (you know your colleagues).
- ✓ Multi-site storage ... is this an issue ?

# Where to store

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- ✓ On-site or off-site
    - ✓ Access by whom ?
  - ✓ Single site storage location
    - ✓ Lowest cost
    - ✓ Possible limited size
    - ✓ Insurance “risk”
    - ✓ Minimal logistics, single “stores” department
  - ✓ Multi-site storage location
    - ✓ Improved insurance risk
    - ✓ Increased logistics and personnel
-

# How to store ?

## Storage conditions

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- ✓ Storage standards
  - ✓ Die / Wafer IEC62258-3
  - ✓ Def Stan series
    - ✓ 00-60, 61-21, (05-61 for explosives)
- ✓ Monitoring and periodic datalogging of
  - ✓ Humidity
  - ✓ Temperature
  - ✓ Gas purity (where used)
  - ✓ Sampling of inventory and inventory movement.

# How many to store ?

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- ✓ Survival rate
  - ✓ Cost vs. Survival
    - ✓ “cotton wool” vs. “engineers drawer”
  - ✓ Yield calculation
  - ✓ Prediction of demand
    - ✓ Quantity per unit time
    - ✓ Quantity per product
    - ✓ Type of demand (linear, sporadic, lumped)
  - ✓ Product / project share
-

# What to store

## Assembled Product.

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### ✓ Pro

- ✓ Known quantity and quality for storage
- ✓ “Ready for action”!!!

### ✓ Con

- ✓ Cost of “manufacture”
  - ✓ Risk of wasted effort
  - ✓ Can I “sell” product in any/all events?
  - ✓ Physical storage generally larger
    - ✓ Increased “types” of components inside leads to complicated storage issues.
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# What to store

## If I store the component product.

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### ✓ Pro

- ✓ Small form factor for storage
- ✓ “Resellable” or viable asset
- ✓ Component already “assessed”
- ✓ Easily handled & packaged ... “*understood by all*”
  - ✓ Bagged, tagged, tubed and boxed.
- ✓ Simple storage on-site
- ✓ Deliverable on a “one-by-one” basis, if needed.

### ✓ Con

- ✓ Inflexible – cannot accommodate package or product change
  - ✓ Storage effects on lead finish and package needs consideration
    - ✓ Lead oxidization
    - ✓ Moisture ingress
  - ✓ Possibly more delicate, higher risk of damage
    - ✓ Inert atmosphere storage
  - ✓ Requires some final assembly
    - ✓ Manufacturing equipment & “know-how”
    - ✓ Test and measurement equipment
  - ✓ Easily “borrowed” for other projects !
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# What to store

## If I store die and/or wafer product.

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- ✓ Pro
    - ✓ Smallest form factor for storage, also often the cheapest.
    - ✓ “Resellable” or viable asset, possibly
    - ✓ Flexible – can accommodate package or product change
    - ✓ Not easily “commandeered” for other projects !
  - ✓ Con
    - ✓ Component only partially “assessed” ... KGD
    - ✓ Extra work, to know quality/quantity of device.
    - ✓ Delicate, highest risk of damage
    - ✓ Dedicated storage, generally at specialist site by specialists !!!!
      - ✓ Inert gas storage, special cabinets,
      - ✓ Refer to IEC 62258 Part 3
    - ✓ Requires assembly
      - ✓ Assembly equipment and “know-how”
      - ✓ Test and measurement equipment
      - ✓ Assembly Personnel
    - ✓ Only really viable on a batch basis, not “one-by-one”.
    - ✓ Not all “components” may have been stored (packages, lids etc.,)
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# How to store ?

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- ✓ Types of storage
  - ✓ Robustness of item
    - ✓ Analyse how to destroy the item
    - ✓ Emplace preventative methods
  - ✓ Suitable packing and protection materials
    - ✓ Specialist suppliers of materials (HiTech)
  - ✓ Access to stored items
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# Notes

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- ✓ **DON'T KEEP DOING AN INVENTORY CHECK!**
    - ✓ Stop “disturbing” the stored product, trust your paperwork ...
  - ✓ Easy to provide conductive paths between “pins” of Assembly and Device for ESD protection
    - ✓ Not so easy for die/wafer !!!
  - ✓ Easy to physically handle larger parts ... whether you should or not
    - ✓ Die/wafer ALWAYS require specialist handling
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# When to store

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- ✓ Can I obtain the items to store ?
    - ✓ Cost vs. timing
    - ✓ Project / item lifetime
    - ✓ Whereabouts in item life-cycle are we ?
  - ✓ Timing of setting up storage facility
    - ✓ Packing, handling & bagging equipment
    - ✓ Actual storage are allocation
    - ✓ Dry N<sub>2</sub> or inert gas supply
  - ✓ Life-time under storage ?
    - ✓ Known shelf-life
    - ✓ Stock rotation
    - ✓ Call off rate
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# Accompanying Paperwork ?

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- ✓ Documentation needed
    - ✓ Data sheets, Specifications
    - ✓ Test results, Wafer maps Electronic media
      - ✓ Long-term reliability
        - ✓ Oxide shedding on magnetic media
        - ✓ CD's & CDR's unreadable
      - ✓ File Format issues
  
  - ✓ What storage medium ?
    - ✓ At least Paper has a reasonable track record !
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# Preparing die/wafer for storage

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- ✓ Again, only **TESTED** product should be stored!!
- ✓ If wafer is to be stored, then the wafer should
  - ✓ either be inked,
  - ✓ or stored with the wafer map in future-readable form !!!
- ✓ If die product is to be stored, then separated singulated known-good-die only should stored.

# Mounting Properties of Tape

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- ✓ Chemical Properties
- ✓ Tack / adhesion level
- ✓ Movement
- ✓ Migration
- ✓ UV exposure (for UV release tape)

# Die Storage Containers

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- ✓ Wafer Vial
- ✓ Wafer Cassette
- ✓ Sawn wafer on film & frame
- ✓ Tape and Reel
- ✓ Waffle Pack
- ✓ Gel Pack®

# Historical Storage

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- ✓ We have been storing die/wafers for over 15 years, with few problems, but :
  - ✓ This is OLD technology !
    - ✓ 10u to 7u SLM/DLM, poly if you're lucky !
  - ✓ It was BUILT and DESIGNED to last
    - ✓ Generally military-type or military sponsored.
  - ✓ The technology was COARSE, RUGGED and ROBUST
    - ✓ Bipolar, PMOS, NMOS or MG CMOS
    - ✓ ESD specifications easily met (most of the time)

# How to damage die product ...

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- ✓ Methods of destroying die products ...
    - ✓ Mechanical & Thermal
      - ✓ Breakage's and fractures
      - ✓ Visual defects, changing criteria
    - ✓ Chemical
      - ✓ Ionic contamination
    - ✓ Electrical & Radiation
      - ✓ ESD Damage
      - ✓ Prolonged UV
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# Mechanical Damage

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- ✓ Damage to active area of die / wafer
  - ✓ Cracking or crazing of passivation
  - ✓ Damage to die underside
  - ✓ Damage to exposed contact areas
    - ✓ e.g. Bond Pads
  - ✓ Failure at visual inspection
    - ✓ Mechanical surface contaminants
    - ✓ Compromised integrity of seal-ring
  - ✓ Piezo-effect
    - ✓ Changing electrical parameters through in-built stress
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# The Storage conditions : Mechanical (1)

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- ✓ Die mechanical protection
    - ✓ Initial placement (accuracy of carrier geometry)
    - ✓ Whilst in storage
    - ✓ Die removal
  
  - ✓ Vibration
    - ✓ Movement during storage
    - ✓ Inappropriate inspection
  
  - ✓ Die / wafer orientation
    - ✓ MEMS product
    - ✓ Abrasion and adhesion of foreign matter to surfaces.
    - ✓ “dust collects on flat surfaces ....”
    - ✓ Anti-bug & bacterial protection !!!
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# The Storage conditions : Mechanical (2)

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- ✓ Anti-vibration // Anti-shock packing.
  - ✓ Thermal Conditions : ~ 17-25°C
    - ✓ Min & Max conditions
    - ✓ Abnormal temperature excursions
  - ✓ Humidity: ~ RH 10%-40%
    - ✓ Not too low (< 10%)
      - ✓ to prevent build-up of electrostatic fields.
    - ✓ Not too high (> 40%)
      - ✓ to prevent condensation and moisture ingress.
  - ✓ Use of dessicants ?
    - ✓ Mechanical abrasion of particulates
    - ✓ Long-term effects ?
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# Chemical Damage

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- ✓ Ionic contamination of active area
    - ✓ Induced by poor pre-storage handling
    - ✓ Contaminant mobility through Silicon
    - ✓ Direct contact of contaminants
    - ✓ Proximity of contaminants
  - ✓ Intermetallic growths
    - ✓ Contact areas
    - ✓ Active areas
    - ✓ Backside contacts
  - ✓ Exotic III-V material sensitivities
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# The Storage conditions : Chemical (1)

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- ✓ Vacuum packing
    - ✓ Encourages ingress of contaminants through packing materials
    - ✓ Addition of desiccants can cause minor particles to be present
  - ✓ Positive pressure systems
    - ✓ Require good inlet filtering
    - ✓ Keeps major contaminants out
    - ✓ Abnormally high N<sub>2</sub> content in atmosphere
      - ✓ monitor O<sub>2</sub> levels for any human operation in proximity !!!
  - ✓ Use of bio-degradable material
    - ✓ Issues with known deterioration
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# The Storage conditions : Chemical (2)

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- ✓ Airborne contaminants
    - ✓ High content of airborne Sulphur compounds in many 3rd world countries
  - ✓ Storage in inert atmosphere
    - ✓ Dry Nitrogen preferred
    - ✓ Alternatives include the noble gasses : Helium, Argon, Neon etc.,
  - ✓ Proximity of “active” reagent sources
  - ✓ Anti-static coatings can “flake” or rub off.
  - ✓ Ingress of active reagents (deterioration)
    - ✓ Sulphur from rubber bands
    - ✓ Chlorine from cardboard / paper
    - ✓ Fluorine from “Pink” antistatic foam
    - ✓ Ammonia from some papers & plastics
    - ✓ Formic & Acetic acids from some plastics & silicone sealants
    - ✓ Other chemical attacks
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# Electrical Damage

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- ✓ ESD field damage
  - ✓ PN Junction damage
  - ✓ FOX-GOX breakdown / puncturing
- ✓ Sensitive parameter shifting
  - ✓ Change  $V_t$  from trapped  $Q_{ss}$  charge
  - ✓ Change  $I_{off}/V_{off}$  parameters
- ✓ Leakage “damage”
  - ✓ FLASH, EEPROM etc., exhibiting corrupt data.

# The Storage conditions : Electrical (1)

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- ✓ ES damage
  - ✓ Inappropriate packing materials
  - ✓ RH too low
  - ✓ Proximity to ES or EM field sources
- ✓ Poor initial testing
  - ✓ Stored with initial damage
    - ✓ “Walking wounded” scenario

# The Storage conditions : Electrical (2)

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- ✓ Subjection to irradiation
    - ✓ Nuclear (high background)
    - ✓ EMR ... local RF and microwave sources
      - ✓ Mobile Phone transmitters, microwave heaters
    - ✓ U.V. & X-Ray sensitivity
    - ✓ Photovoltaic effects on sensitive analog die.
  - ✓ Effects caused by “ageing” on proximity materials
    - ✓ Polymerisation of specific plastics
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# Who's involved ?

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The Manufacturer

The Storage house

The Packing material supplier

The End User / Customer

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# Information needed from the **MANUFACTURER**

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- ✓ Recommendations from Manufacturer as to known issues with packing materials
    - ✓ “Tacky-back” permitted for 12 months max.
  - ✓ Expected lifetimes of Manufacturer supplied packing materials
    - ✓ Particularly those regarded specifically as
      - ✓ Transient packing
      - ✓ Temporary packing
  - ✓ Known sensitivities of specific technologies
  - ✓ Any recommended pre- and post-storage processes that may enhance the storage life.
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## Information needed from the **STORAGE** house.

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- ✓ Die & wafer traceability
  - ✓ Actual age of silicon die
    - ✓ Not shown on final date code
  - ✓ Silicon technology
    - ✓ Known sensitivity to external effects
    - ✓ Clearly marked packages, including static sensitivity
  - ✓ Storage conditions (die history)
    - ✓ Min-Max conditions
    - ✓ Abnormal or adverse conditions that have been applied to die or wafers during storage
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## Information needed from the **Packaging Materials supplier.**

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- ✓ Are there any known mechanical, electrical or chemical degradation ?
  - ✓ What known sensitivities of the supplied materials ?
    - ✓ Existing reports
    - ✓ Material details and processing
    - ✓ susceptibilities to chemical reagents, radiation, etc.,
  - ✓ Recommendations on storage and lifetimes
-

# Information needed from The Customer

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- ✓ How long do the components need to be stored ?
    - ✓ This will affect the approach taken for storage.
  - ✓ What call-off rate is expected ?
    - ✓ How often do the containers have to be opened
  - ✓ What periodic inspection is required ?
  - ✓ Are there any pre- or post-conditioning requirements ?
-

# Unknown Issues (1)

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- ✓ New processing materials and properties :
    - ✓ Copper metalization
      - ✓ Copper is chemically active,
        - ✓ has active oxides :                      Cuprite, Chalcotrichite, Tenorite etc.,
        - ✓ has active sulphides :                      Chalcocite, Bornite etc.,
      - ✓ Aluminium relatively passive, inert oxide
    - ✓ Bump materials
      - ✓ Novel intermetallics
      - ✓ Tin “whiskering” on new Pb-free Solder bumps ?
    - ✓ Passivation / Glassivation materials
      - ✓ Lifetime of new polyimides etc.,
    - ✓ Exotic semiconductor materials
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# Unknown Issues (2)

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- ✓ Die geometry shrinking
    - ✓ Increased sensitivity to ES field damage
    - ✓ Increased sensitivity to minor contamination
    - ✓ Increased sensitivity to marginal processing and in-built defects
    - ✓ Unknown “survivability” beyond the life of a PC or cell-phone
  - ✓ Some product now is neither **designed** nor manufactured for longevity.
  - ✓ Unknown issues when re-packaging / re-assembling
    - ✓ Availability of “other” items in build list.
  - ✓ Consider the total operation of storage and it’s possible effect on the environment and local health / safety legislation and regulations
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# Unknown Issues (MEMS)

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- ✓ Storage sensitivities will be dependant upon MS type :
    - ✓ Biological
    - ✓ Chemical
      - ✓ Gas or liquid
    - ✓ Mechanical movement
      - ✓ Electrostatic
      - ✓ Thermo-cycle
      - ✓ Piezo-mechanical
    - ✓ Fluidic (pressure etc.,)
    - ✓ Mechanical sensing
      - ✓ Acceleration
      - ✓ Vibration
    - ✓ Field/extraneous sensing
      - ✓ Magnetic
      - ✓ Electrostatic
      - ✓ Radiation
-

# Initial conclusions

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- ✓ Manufacturers consider the delivery packing to be **TEMPORARY** only
  - ✓ Traceability needed throughout storage.
  - ✓ Controlled Temperature & Humidity
    - ✓ 21°C, ± 4°C and 30%RH ± 10% @ 1 At (STP)
  - ✓ Consider localised conditions
    - ✓ Anti-static precautions
    - ✓ Proximity of unknown or hazardous materials
    - ✓ Anti-shock & anti-vibration
    - ✓ Limit exposure to radiation where possible
    - ✓ Orientation of storage
-